08/19/00 15:08 P nno/n12

07-24-2000

FORM PTO-1595 (Rev. 6-93) OMB No. 0651-0011 (Exp. 4/94) RECORDATION FORM REGORDATION FORM PATENTS	ONLY 101412713			
To the honorable Commissioner of Patents and Trademarks: Please record the attached original documents or copy thereof.				
1. Name of conveying party(ics): ORBOT INSTRUMENTS, LIMITED Additional name(s) of conveying party(ics) attached? Yes No	 Name and address of receiving party(ies): APPLIED MATERIALS, INC. P.O. Box 450A Santa Clara, California 95052 			
3. Nature of Conveyance:				
[X] Assignment [] Merger				
Security Agreement Change of Name Change of Name	Additional name(s) attached? [] Yes [X] No			
Execution Date: 12 MAY 2000				
4. Application number(s) or patent number(s) If this document is being filed together with a new application, the execution date of the application is: A. Patent Application No.(s) B. Patent No.(s)				
	5,699,447			
Additional numbers attached? [X] Yes [] No				
Name and address of party to whom correspondence concerning document should be mailed:	6. Total number of application and patems involved: 26			
Applied Materials, Inc. Attn: Patent Group 2881 Scott Blvd., M/S 2061	7. Total Fcc (37 CFR 3.41)			
Santa Clara, CA 95050	8. Deposit account number: 50-1074 (Attach duplicate copy of this page if paying by deposit account)			
DO NOT USE THIS SPACE				
9. Statement and signature. To the best of my knowledge and belief, the foregoing information is document.	true and correct and any attached copy is a true copy of the origina			
Reg. No.: 44,417 Name of Person Signing: Peter J. Yim Signature: Date: May 25, 2000				
Total number of pages including cover sheet, attachments, and document: 3				
CERTIFICATE OF MAILING PURSUANT TO 37 C.F.R. § 1.8	Date of Deposit: May 25, 2000			
I hereby certify that this paper or fee is being deposited with the United States Postal Service with sufficient postage as first class mail in an empursuant to 37 CFR 1.8 on the date indicated above and is addressed to the Honorable Commissioner of Patents and Trademarks, Box Assigna Washington, D.C. 2023 1.				
Date: May 25, 2000 By: Vladimir Skliba				

439971 v1/PA

PATENT

REEL: 010927 FRAME: 0157

7 17.	
Pat. No.	
5,982,921	i
5,619,429	
5,586,058	
5,619,588	
5,907,628	
5,892,579	
5,797,317	
5,466,940	1
5,644,132	١
5,659,172	١
5,311,288	1
4,941,980	1
4,714,833	1
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4,831,266	1
4,896,036	4
4,954,705	┨
5,021,670	
5,146,090	
5,329,125	
5,428,442	
B1 RE 33,956	
RE 33,956	_
5,854,674	_
4,811,409	_
5,172,000	_
<u>i</u>	_

2.

PATENT REEL: 010927 FRAME: 0158

PATENT ASSIGNMENT

WHEREAS, ORBOT INSTRUMENTS, LIMITED, having offices in Yavne, Israel, (hereinafter referred to as "Assignor") owns rights and interest in and to the U.S. utility patents listed on the attached Schedule A (hereinafter referred to as "Existing Patents"); and

WHEREAS, APPLIED MATERIALS, INCORPORATED, having offices in California, United States of America (hereinafter referred to as "Assignee"), desires to acquire Assignor's entire rights and interests in and to Existing Patents, and in and to the inventions disclosed in said Existing Patents, and to the Future Patents (as hereinafter defined) as successor to the business of Assignor, which business is ongoing and existing.

NOW THEREFORE, for and in consideration of One Dollar (\$1.00) and other good and valuable consideration, the receipt and sufficiency of which is hereby acknowledged, Assignor does hereby sell, assign and transfer unto said Assignee, its successors, assigns and legal representatives, Assignor's full rights and interests in and to said Existing Patents, and to all future patents which may be granted therefor throughout the world, and all division, reissues, substitutions, continuations, continuations-in-part and extensions thereof (collectively, "Future Patents"), together with all claims, causes of action and damages for past infringement, if any, of said Existing Patents and Future Patents; and Assignor hereby authorizes and requests the United States Patent and Trademark Office and other patent offices throughout the world to issue all Future Patents resulting therefrom insofar as Assignor's interest is concerned, to the said Assignee of Assignor's entire right, title and interest.

Assignor also hereby sells and assignees to Assignee, its successors, assigns and legal representatives Assignor's full rights and interests to inventions disclosed in said Existing Patents and Future Patents throughout the world, including the right to file applications and obtain patents, utility models, industrial models and designs for said inventions in Assignee's own name throughout the world including all rights of priority, all rights to publish cautionary notices reserving ownership of said inventions and all rights to register said inventions in appropriate registries; and Assignor further agrees to execute any and all powers of attorney, applications, assignments, declarations, affidavits, and any other papers in connection therewith reasonably necessary to perfect such right, title and interest in Assignee, its successors, assigns and legal representatives.

Assignor hereby further agrees that Assignor will communicate to said Assignce, or to its successors, assigns and legal representatives, any facts known to Assignor respecting any improvements, and, at the expense of said Assignee, will testify in any legal proceedings, sign all lawful papers, execute all divisional, continuation, continuation-in-part, reissue and substitute applications, make all lawful oaths, and general do everything possible to vest title in said Assignee and to aid said Assignee, its successors, assigns and legal representatives in obtaining and enforcing proper protection for said Existing Patents and Future Patents in such countries as Assignee may elect.

IN WITNESS WHEREOF, Assignor has caused this instrument to be executed effective May 12, 2000.

ORBOT INSTRUMENTS, LIMITED

By: ney, President Name and Title: Joseph

1.

PATENT REEL: 010927 FRAME: 0159

SCHEDULE A

PAT. NO.	TITLE	ISSUE DATE
5,699,447	TWO-PHASE OPTICAL INSPECTION METHOD AND APPARATUS	16 DEC 1997
3,077,747	FOR DEFECT DETECTION	TO DEC 1777
5,982,921	OPTICAL INSPECTION METHOD AND APPARATUS	9 NOV 1999
5,619,429	APPARATUS AND METHOD FOR INSPECTION OF A PATTERNED	8 APR 1997
,	OBJECT BY COMPARISON THEREOF TO A REFERENCE	
5,586,058	APPARATUS AND METHOD FOR INSPECTION OF A PATTERNED	17 DEC 1996
	OBJECT BY COMPARISON THEREOF TO A REFERENCE	
5,619,588	APPARATUS AND METHOD FOR COMPARING AND ALIGNING	8 APR 1997
	TWO DIGITAL REPRESENTATIONS OF AN IMAGE	\
5,907,628	APPARATUS AND METHOD FOR COMPARING AND ALIGNING	25 MAY 1999
£ 600 £ 20	TWO DIGITAL REPRESENTATIONS OF AN IMAGE OPTICAL INSPECTION METHOD AND APPARATUS	6 APR 1999
5,892,579	UNIVERSAL CHUCK FOR HOLDING PLATES OF VARIOUS SIZES	25 AUG 1999
5,797,317	ELECTRON DETECTOR WITH HIGH BACKSCATTERED	14 NOV 1995
5,466,940	ELECTRON ACCEPTANCE FOR PARTICLE BEAM APPARATUS	14 140 4 1993
5,644,132	SYSTEM FOR HIGH RESOLUTION IMAGING AND	1 JUL 1997
3,044,132	MEASUREMENT OF TOPOGRAPHIC AND MATERIAL FEATURES	1 JOE 1777
	ON A SPECIMEN	
5,659,172	RELIABLE DEFECT DETECTION USING MULTIPLE PERSPECTIVE	19 AUG 199
3,000,1	SCANNING ELECTRON MICROSCOPE IMAGES	
5,311,288	METHOD AND APPARATUS FOR DETECTING SURFACE	10 MAY 199
•	DEVIATIONS FROM A REFERENCE PLANE	
4,941,980	SYSTEM FOR MEASURING A TOPOGRAPHICAL FEATURE ON A	17 JUL 1990
	SPECIMEN	
4,714,833	ARRANGEMENT FOR DETECTING SECONDARY AND/OR	22 DEC 198
	BACKSCATTER ELECTRONS IN AN ELECTRON BEAM	1
	APPARATUS	16 MAY 15
4,831,266	DETECTOR OBJECTIVE FOR PARTICLE BEAM APPARATUS	23 JAN 19
4,896,036	DETECTOR OBJECTIVE FOR SCANNING MICROSCOPES METHOD FOR EXAMINING A SPECIMEN IN A PARTICLE BEAM	4 SEP 1990
4,954,705	INSTRUMENT	4 SEF 1990
5,021,670	MULTIPOLE ELEMENT	4 JUN 199
5,146,090	PARTICLE BEAM APPARATUS HAVING AN IMMERSION LENS	8 SEP 199
5,1 10,05 0	ARRANGED IN AN INTERMEDIATE IMAGE OF THE BEAM	
5,329,125	DEVICE FOR CORPUSCULAR-OPTICAL EXAMINATION AND/OR	12 JUL 19
, .	PROCESING OF MATERIAL SAMPLES	
5,428,442	INSPECTION SYSTEM FOR IN-LENS, OFF-AXIS ILLUMINATION	27 JUN 1
BI RE 33,956	INSPECTION SYSTEM FOR IN-LENS, OFF-AXIS ILLUMINATION	7 JUN 19
RE 33,956	INSPECTION SYSTEM FOR IN-LENS, OFF-AXIS ILLUMINATION	9 JUN 15
5,854,674	METHOD OF HIGH SPEED, HIGH DETECTION SENSITIVITY	29 DEC
	INSPECTION OF REPETITIVE AND RANDOM SPECIMEN	
	PATTERNS	7 MAR
4,811,409	METHOD AND APPARATUS FOR DETECTING DEFECT INFORMATION IN A HOLOGRAPHIC IMAGE PATTERN	/ IVIALK
5 172 000	SPATIAL FILTER FOR OPTICALLY BASED DEFECT INSPECTION	15 DEC
5,172,000	SYSTEM	13 2200
	J	

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PATENT REEL: 010927 FRAME: 0160